TOSHIBA CCD Linear Image Sensor CCD (Charge Coupled Device)

TCD2724DG-1



TOSHIBA CCD Linear Image Sensor CCD (Charge Coupled Device)

TCD2724DG-1

The TCD2724DG-1 is a high sensitive and low dark current 7450 elements \times 3 lines CCD color linear image sensor.

The device contains a row of 7450 elements \times 3 lines photodiodes which provide 24 lines/mm across a A3 size paper. The device is operated by 3.3 V pulse and 10 V power supply.

WDIP22-G-400-2.54

Features

- Number of Image Sensing Elements: 7450 elements × 3 lines
- Image Sensing Element Size: 4.7 μm by 4.7 μm on 4.7 μm center
- Photo Sensing Region: High sensitive PN photodiode
- Clock: 2-phase (3.3 V)
- Power Supply Voltage: 10 V (typ.)
- Distance between Photodiode Array: 18.8 μm (4 lines) R array G array, G array B array
- Internal Circuit: Clamp circuit, Sample and hold circuit, Low input capacitance
- Package: 22 pin CERDIPColor Filter: Red, Green, Blue

ABSOLUTE MAXIMUM RATINGS (Note 1)

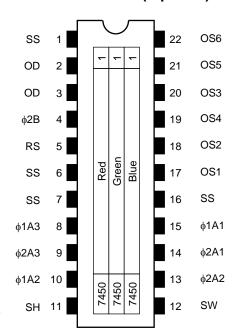
Characteristics	Symbol	Rating	Unit
Clock pulse voltage	$V_{\phi A}$		
Last stage clock pulse voltage	$V_{\phi B}$		
Shift pulse voltage	VsH	-0.3 to +8.0	V
Reset pulse voltage	V _{RS}		
Switch pulse voltage	Vsw		
Power supply voltage	Vod	-0.3 to +13.5	V
Operating temperature	T _{opr}	0 to 60	°C
Storage temperature	T _{stg}	-25 to +85	°C

Note 1: All voltages are with respect to SS terminals (ground).

None of the ABSOLUTE MAXIMUM RATINGS must be exceeded, even instantaneously.

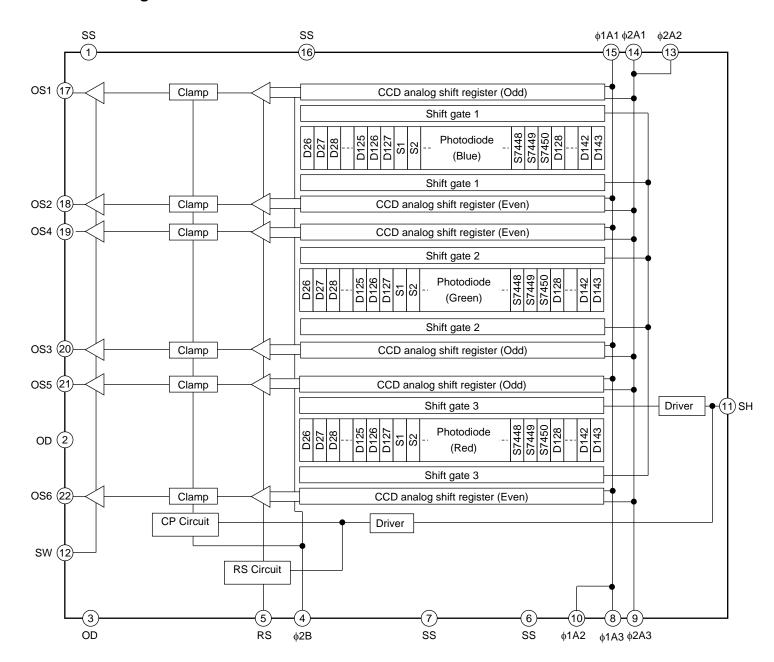
If any one of the ABSOLUTE MAXIMUM RATINGS is exceeded, the electrical characteristics, reliability and life time of the device cannot be guaranteed. If the ABSOLUTE MAXIMUM RATINGS are exceeded, the device can be permanently damaged or degraded. Create a system design in such a manner that any of the ABSOLUTE MAXIMUM RATINGS will not be exceeded under any circumstances.

Pin Connections (top view)





Circuit Diagram



Pin Names

Pin No.	Symbol	Name	Pin No.	Symbol	Name
1	SS	Ground	22	OS6	Output signal 6 (Red(Even))
2	OD	Power supply	21	OS5	Output signal 5 (Red(Odd))
3	OD	Power supply	20	OS3	Output signal 3 (Green(Odd))
4	ф2В	Last stage transfer clock (phase 2)	19	OS4	Output signal 4 (Green(Even))
5	RS	Reset gate	18	OS2	Output signal 2 (Blue(Even))
6	SS	Ground	17	OS1	Output signal 1 (Blue(Odd))
7	SS	Ground	16	SS	Ground
8	φ1A3	Transfer clock 3 (phase 1)	15	φ1A1	Transfer clock 1 (phase 1)
9	ф2А3	Transfer clock 3 (phase 2)	14	φ2A1	Transfer clock 1 (phase 2)
10	φ1A2	Transfer clock 2 (phase 1)	13	φ2A2	Transfer clock 2 (phase 2)
11	SH	Shift gate	12	SW	Switch gate (Sample and hold output select)

© 2017



Optical/Electrical Characteristics

Ta = 25°C, VoD = 10 V, V $_{\phi}$ = VRS = VSH = 3.3 V (pulse), f $_{\phi}$ = 1.0 MHz, tint (integration time) = 10 ms, light source = A light source + CM500S (t = 1.0 mm)

Characteristics		Symbol	Min	Тур.	Max	Unit	Note	
	Red	R _R	9.0	12.8	16.6			
Sensitivity	Green	RG	10.5	15.0	19.5			
Enable sample and hold	Blue	R _B	3.6	5.2	6.8	V/lx⋅s	(Nata 0)	
On and the state of	Red	R _R	10.0	14.3	18.6	V/IX·S	(Note 2)	
Sensitivity	Green	RG	11.8	16.9	22.0			
Disable sample and hold	Blue	R _B	4.0	5.8	7.5			
Photo response non uniformity		PRNU (1)	_	5	20	%	(Note 3)	
		PRNU (3)	_	3	12	mV	(Note 4)	
Saturation output voltage		Vsat	1.2	1.8	_	V	(Note 5)	
Saturation exposure		SE	0.05	0.1	_	lx⋅s	(Note 6)	
Dark signal voltage		VDRK	_	0.5	6	mV	(Note 7)	
Dark signal non uniformity		DSNU	_	10	12	mV	(Note 8)	
DC power dissipation		PD	_	700	1050	mW	_	
Total transfer efficiency		TTE	92	97	_	%	_	
Output impedance		ZO	_	0.2	0.5	kΩ	_	
DC output signal voltage		Vos	3.7	5.2	6.7	V	(Note 9)	
Random noise (Enable sample and hold)			_	1.4	_		(NI=1= 40)	
Random noise (Disable sample and hold)		$N_{D\sigma}$	_	1.1	_	mV	(Note 10)	

Note 2: Sensitivity is defined for each color of signal outputs average when the photosensitive surface is applied with the light of uniform illumination and uniform color temperature.

Note 3: PRNU (1) is defined for each color on a single chip by the expressions below when the photosensitive surface is applied with the light of uniform illumination and uniform color temperature, where measured approximately 600 mV of signal output.

PRNU (1) =
$$\frac{\Delta X}{\overline{X}} \times 100$$
 (%)

 \overline{X} : Average of total signal outputs

 ΔX : The maximum deviation from \overline{X}

Note 4: PRNU (3) is defined as the maximum voltage with next pixel, where measured approximately 50 mV of signal output.

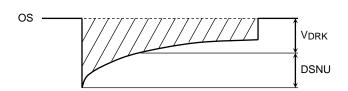
Note 5: VSAT is defined as the minimum saturation output voltage of all effective pixels.

Note 6: Definition of SE:

$$SE = \frac{V_{SAT}}{R_G}$$

Note 7: VDRK is defined as average dark signal voltage of all effective pixels.

Note 8: DSNU is defined by the difference between average value (VDRK) and the maximum value of the dark voltage.

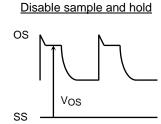




Note 9: DC output signal voltage is defined as follows.

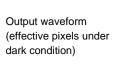
Video signal with sample and hold represents the dummy outputs period.

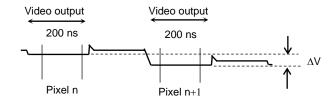
OS Vos



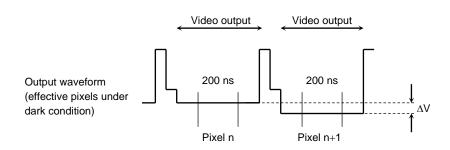
Note 10: Random noise is defined as the standard deviation (sigma) of the output level difference between two adjacent effective pixels under no illumination (i.e. dark condition) calculated by the following procedure.

Enable sample and hold





Disable sample and hold



- 1) Two adjacent pixels (pixel n and n+1) in one reading are fixed as measurement points.
- 2) Each of the output levels at video output periods averaged over 200 ns period to get V(n) and V(n+1).
- 3) V(n+1) is subtracted from V(n) to get ΔV .

$$\Delta V = V(n) - V(n{+}1)$$

4) The standard deviation of ΔV is calculated after procedure 2) and 3) are repeated 30 times (30 readings).

$$\overline{\Delta V} = \frac{1}{30} \sum_{i=1}^{30} \! \left| \Delta Vi \right|$$

$$\sigma = \sqrt{\frac{1}{30} \sum_{i=1}^{30} \! \! \left(\!\! \left| \Delta Vi \right| \! - \! \overline{\Delta V} \right)^{\! 2}}$$

- 5) Procedure 2), 3) and 4) are repeated 10 times to get sigma value.
- 6) 10 sigma values are averaged.

$$\overline{\sigma} = \frac{1}{10} \sum_{j=1}^{10} \sigma_j$$

7) $\bar{\sigma}$ value calculated using the above procedure is observed $\sqrt{2}$ times larger than that measured relative to the ground level. So we specify the random noise as follows.

$$ND_{\sigma} = \frac{1}{\sqrt{2}}\bar{\sigma}$$



Recommended Operating Conditions (Ta = 25°C)

For best performance, the device should be used within the Recommended Operating Conditions.

Characteristics		Symbol	Min	Тур.	Max	Unit
Clock pulse voltage	"H" level	V _{ϕ1A}	3.1	3.3	5.5	V
Clock pulse voltage	"L" level	$V_{\phi 2A}$	0	0	0.1	
Last stage clock pulse	"H" level	Vian	3.1	3.3	5.5	V
voltage	"L" level	V _{ф2B}	0	0	0.1	
Shift pulse voltage	"H" level	VsH	3.1	3.3	5.5	V
	"L" level	VSH	0	0	0.1	
Poset pulse voltage	"H" level	\/po	3.1	3.3	5.5	V
Reset pulse voltage	"L" level	VRS	0	0	0.1	V
Switch pulse voltage	"H" level	Vou	3.1	3.3	5.5	V
	"L" level	V _{SW}	0	0	0.1	V
Power supply voltage		V _{OD}	9.5	10.0	10.5	٧

Clock Characteristics (Ta = 25°C)

For best performance, the device should be used within the Recommended Operating Conditions.

Characteristics	Symbol	Min	Тур.	Max	Unit
Clock pulse frequency	f_{φ}	1.0	1.0	35.0	MHz
Reset pulse frequency	fRS	1.0	1.0	35.0	MHz
Clock capacitance (Note 11)	СфА		65		pF
Last stage clock capacitance	$C_{\phi B}$		7		pF
Shift gate capacitance	Csh		20		pF
Reset gate capacitance	CRS		7		pF

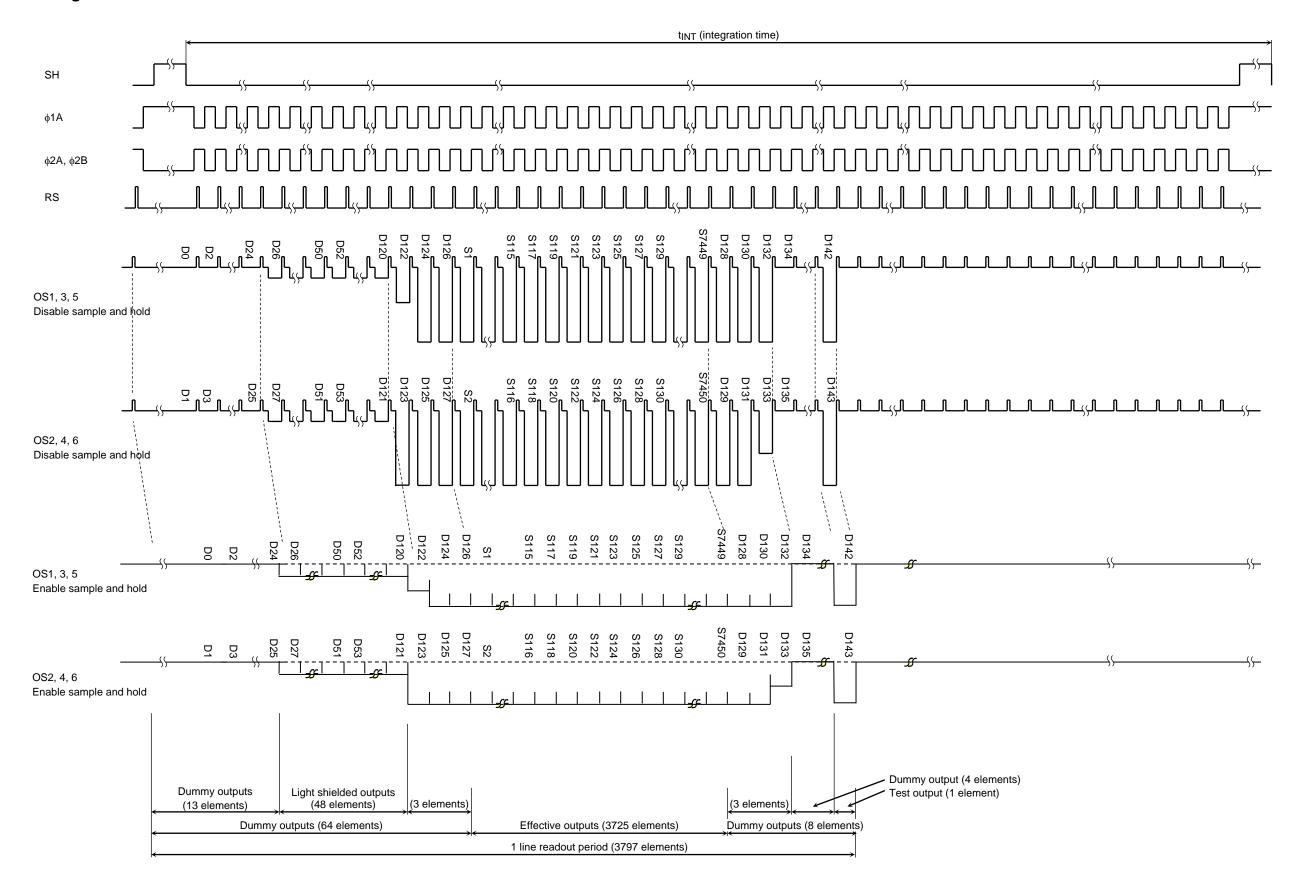
Note 11: VOD = 10 V, Input capacitance per a pin.

Mode Select (Selection Sample and Hold)

Mode	SW
Enable sample and hold	"H"
Disable sample and hold	"L"



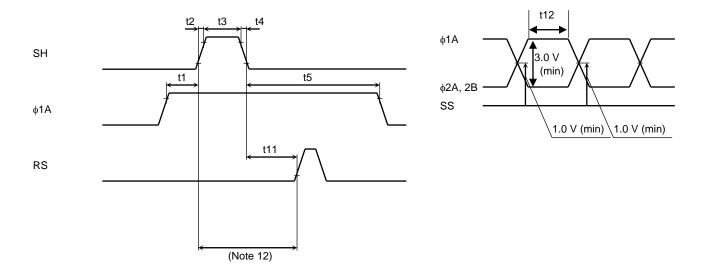
Timing Chart 1



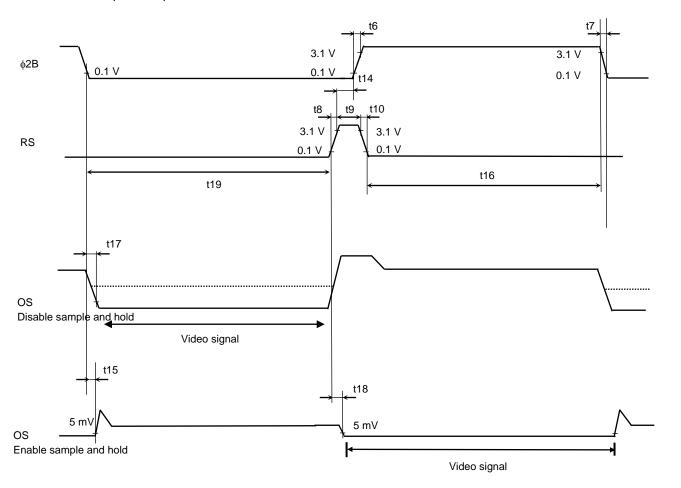
6



Timing Requirements



Note 12: Keep the RS pin "L" level.





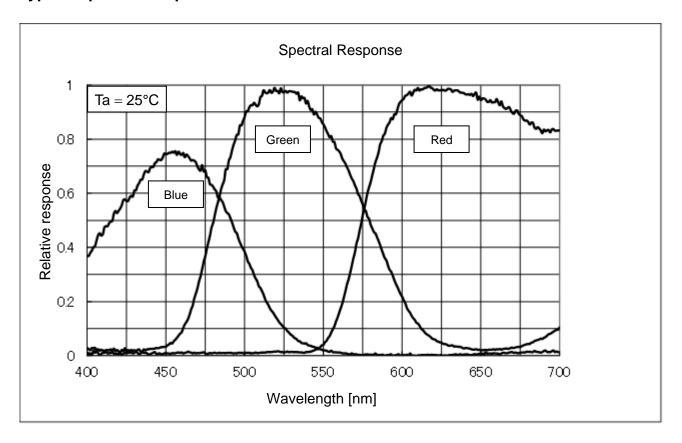
Characteristics	Symbol	Min	Typ. (Note 13)	Max	Unit
Dulga timing of CLL and 14.0	t1	120	1000	_	ns
Pulse timing of SH and φ1A	t5	1000	1200	_	ns
SH pulse rise time, fall time	t2, t4	0	50	_	ns
SH pulse width	t3	2000	5000	_	ns
φ2B pulse rise time, fall time	t6, t7	0	50	_	ns
RS pulse rise time, fall time	t8, t10	0	20	_	ns
RS pulse width	t9	6	100	_	ns
Pulse timing of SH and RS	t11	500	_	_	ns
φ1A, φ2A pulse width	t12	7	100	_	ns
	t14	0	0	_	ns
Pulse timing of φ2B and RS	t16	6	100	_	ns
	t19	8	100	_	ns
Video data delay time	t17		7	_	ns
Video data delay time	t18		7		nc
Enable sample and hold	110	_	,		ns
φ2B pulse timing of OS	t15	_	0	_	ns

Note 13: Measured with fRS = 1 MHz.

8



Typical Spectral Response





Cautions

1. Electrostatic Breakdown

Store in shorting clip or in conductive foam to avoid electrostatic breakdown.

CCD Image Sensor is protected against static electricity, but inferior puncture mode device due to static electricity is sometimes detected. In handing the device, it is necessary to execute the following static electricity preventive measures, in order to prevent the trouble rate increase of the manufacturing system due to static electricity.

- Prevent the generation of static electricity due to friction by making the work with bare hands or by putting a. on cotton gloves and non-charging working clothes.
- Discharge the static electricity by providing earth plate or earth wire on the floor, door or stand of the work b.
- Ground the tools such as soldering iron, radio cutting pliers of or pincer. c.
- lonized air is recommended for discharge when handling CCD image sensors.

It is not necessarily required to execute all precaution items for static electricity.

It is all right to mitigate the precautions by confirming that the trouble rate within the prescribed range.

2. Window Glass

The dust and stain on the glass window of the package degrade optical performance of CCD sensor. Keep the glass window clean by saturating a cotton swab in alcohol and lightly wiping the surface, and allow the glass to dry, by blowing with filtered dry N2. Care should be taken to avoid mechanical or thermal shock because the glass window is easily to damage.

3. Incident Light

CCD sensor is sensitive to infrared light. Note that infrared light component degrades resolution and PRNU of CCD sensor.

Mounting on a PCB

This package is sensitive to mechanical stress.

TOSHIBA recommends using IC inserters for mounting, instead of using lead forming equipment. Since this package is not strong against mechanical stress, you should not reform the lead frame. We recommend to use an IC-inserter when you assemble to PCB.

Soldering

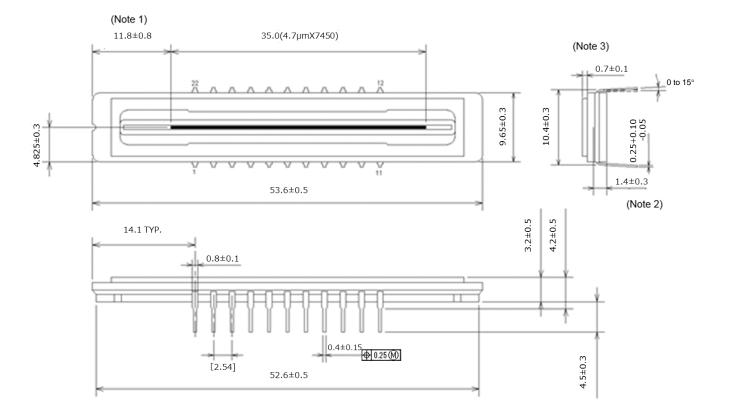
Soldering by the solder flow method cannot be guaranteed because this method may have deleterious effects on prevention of window glass soiling and heat resistance.

Using a soldering iron, complete soldering within three seconds for lead temperatures of up to 350°C.



Package Dimensions

WDIP22-G-400-2.54



Unit: mm

Note 1: Distance between the edge of the package and the first pixel (S1)

Note 2: Distance between the top of chip and bottom of the package

Note 3: Glass thickness (n = 1.5)



RESTRICTIONS ON PRODUCT USE

Toshiba Corporation and its subsidiaries and affiliates are collectively referred to as "TOSHIBA". Hardware, software and systems described in this document are collectively referred to as "Product".

- TOSHIBA reserves the right to make changes to the information in this document and related Product without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before customers use the Product, create designs including the Product, or incorporate the Product into their own applications, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application with which the Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.
- PRODUCT IS NEITHER INTENDED NOR WARRANTED FOR USE IN EQUIPMENTS OR SYSTEMS THAT REQUIRE
 EXTRAORDINARILY HIGH LEVELS OF QUALITY AND/OR RELIABILITY, AND/OR A MALFUNCTION OR FAILURE OF WHICH
 MAY CAUSE LOSS OF HUMAN LIFE, BODILY INJURY, SERIOUS PROPERTY DAMAGE AND/OR SERIOUS PUBLIC IMPACT
 ("UNINTENDED USE"). Except for specific applications as expressly stated in this document, Unintended Use includes, without
 limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, lifesaving and/or life supporting medical
 equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to
 control combustions or explosions, safety devices, elevators and escalators, and devices related to power plant. IF YOU USE
 PRODUCT FOR UNINTENDED USE, TOSHIBA ASSUMES NO LIABILITY FOR PRODUCT. For details, please contact your
 TOSHIBA sales representative or contact us via our website.
- · Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any
 applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE
 FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY
 WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR
 LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND
 LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO
 SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS
 FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without
 limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile
 technology products (mass destruction weapons). Product and related software and technology may be controlled under the
 applicable export laws and regulations including, without limitation, the Japanese Foreign Exchange and Foreign Trade Law and the
 U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited
 except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product.
 Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. TOSHIBA ASSUMES NO LIABILITY FOR DAMAGES OR LOSSES
 OCCURRING AS A RESULT OF NONCOMPLIANCE WITH APPLICABLE LAWS AND REGULATIONS.

TOSHIBA ELECTRONIC DEVICES & STORAGE CORPORATION

https://toshiba.semicon-storage.com/